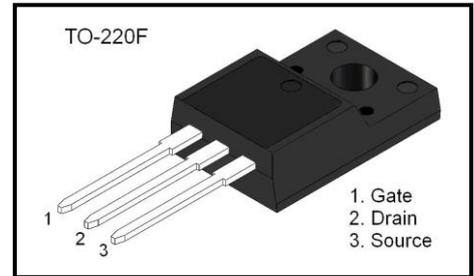
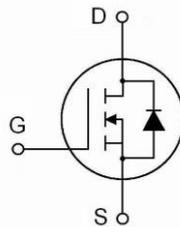


General Description

The 15N65F is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristic. This power MOSFET is usually used in high speed switching applications including power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits

Features

- V_{DS} 650V
- I_D 15A
- $R_{DS(ON)}$ ($V_{GS} = 10V$) $<0.65\Omega$
- Fast Switching Capability
- Avalanche Energy Specified
- Improved dv/dt Capability, High Ruggedness



Absolute Maximum Ratings ($T_A = 25^\circ C$)

Parameter	Symbol	Ratings	Units	
Gate-Drain Voltage	V_{DSS}	650	V	
Gate-Source Voltage	V_{GSS}	± 30	V	
Continuous Drain Current (Note 2)	$T_C=25^\circ C$	I_D	15	A
	Pulsed	I_{DM}	60	
Power Dissipation	P_D	60	W	
Avalanche Energy	Single Pulsed (Note 4)	E_{AS}	637	mJ
	Repetitive (Note 5)	E_{AR}	25	mJ
Peak Diode Recovery dv/dt (Note 5)	dv/dt	4.5	V/ns	
Junction Temperature	T_j	150	$^\circ C$	
Storage Temperature	T_{stg}	-55~150	$^\circ C$	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Drain current limited by maximum junction temperature

3. Repetitive Rating: Pulse width limited by maximum junction temperature

4. $L = 5.2mH$, $I_{AS} = 15A$, $V_{DD} = 50V$, $R_G = 25\Omega$ Starting $T_j = 25^\circ C$

5. $I_{SD} \leq 15A$, $di/dt \leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_j = 25^\circ C$

Thermal Characteristic

Parameter	Symbol	Value	Units
Maximum Thermal Resistance, Junction-case	$R_{\theta JC}$	3.3	$^\circ C/W$
Maximum Thermal Resistance, Junction-Ambient	$R_{\theta JA}$	62.5	$^\circ C/W$

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min.	Typ	Max.	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	650			V
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	$I_D = 250\mu A$, Referenced to 25°C		0.7		$V/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			1	μA
Gate Leakage Current	Forward	I_{GSS}			100	nA
	Reverse				-100	nA
On Characteristics						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	2.0		4.0	V
Drain-source On-Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 7.5A$		0.5	0.65	Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 25V, V_{GS} = 0V$, $f = 1.0\text{MHz}$		2380		pF
Output Capacitance	C_{oss}			295		
Reverse Transfer Capacitance	C_{rss}			23.6		
Switching Characteristics)						
Turn-On Delay Time	$t_{d(on)}$	$V_{DS} = 325V, I_D = 15A$ $R_G = 21.7\Omega$ (Note1, 2)		65		ns
Turn-on Rise Time	t_r			125		
Turn-Off elay Time	$t_{d(off)}$			105		
Turn-Off Fall	t_f			65		
Total Gate Charge	Q_g	$V_{DS} = 520V, I_D = 15A$ $V_{GS} = 10V$ (Note1, 2)		48.5		nC
Gate-Source Charge	Q_{gs}			14		
Gate-Drain Charge	Q_{gd}			21.2		
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S = 15A$			1.4	V
Diode Forward Current	I_S	-			15	A
Pulsed Diode Forward Current	I_{SM}				60	A
Reverse Recovery Time	t_{rr}	$I_S = 15A, V_{GS} = 0V$ $dI_F/dt = 100A/\mu s$ (Note 1)		496		ns
Reverse Recovery Charge	Q_{rr}				5.7	

Notes: 1. Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

2. Essentially independent of operating temperature

Test Circuits and Waveforms

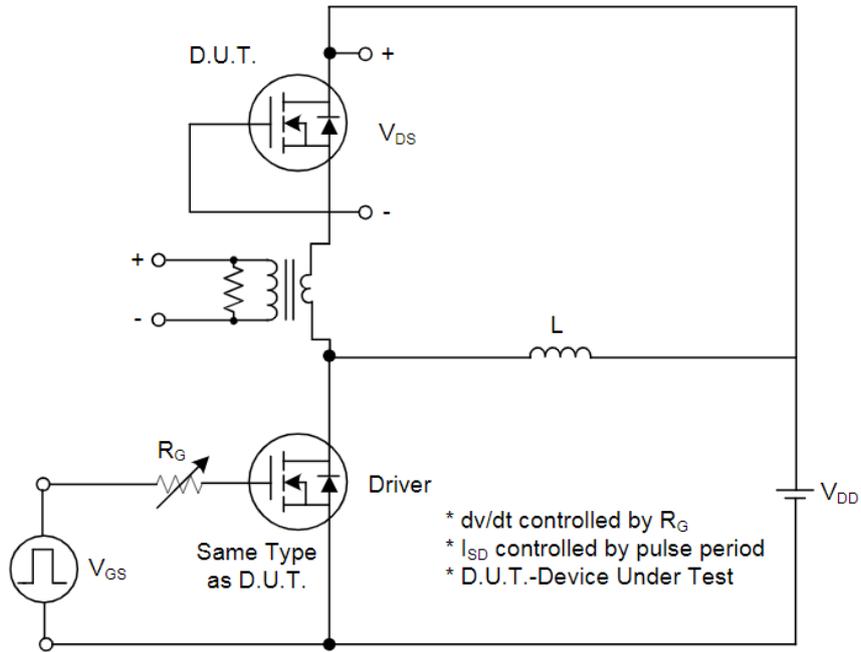


Figure 1. Peak Diode Recovery dv/dt Test Circuit

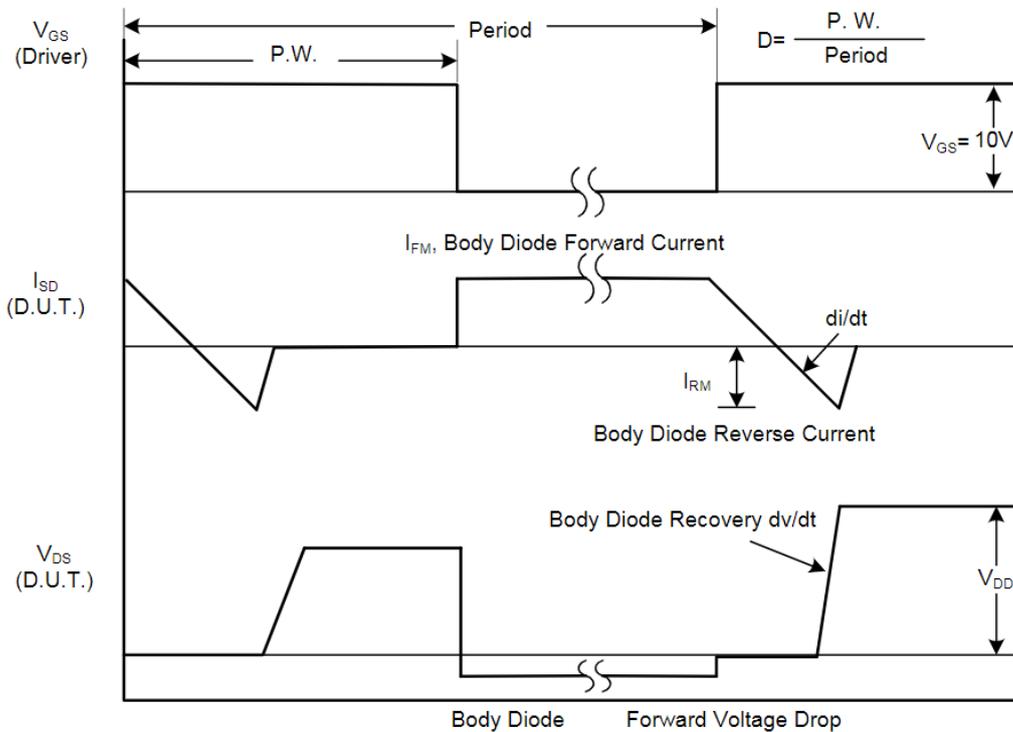


Figure 2. Peak Diode Recovery dv/dt Waveforms

Test Circuits and Waveforms

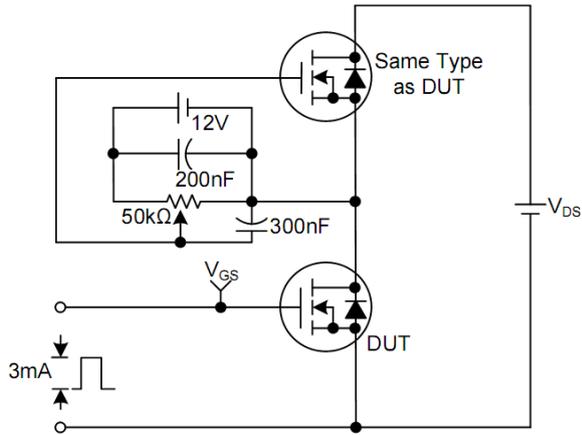


Figure 3. Gate Charge Test Circuit

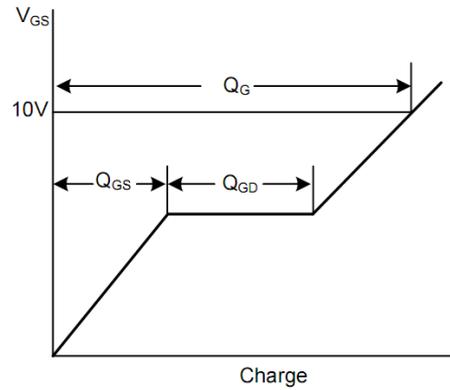


Figure 4. Gate Charge Waveforms

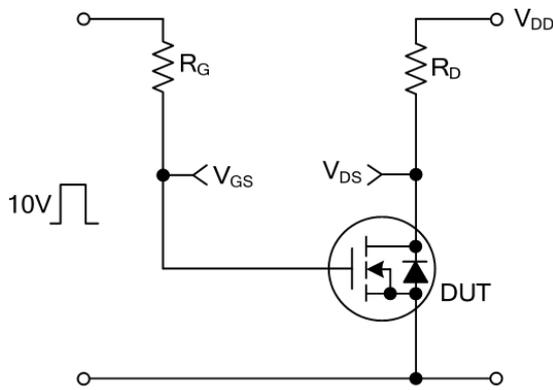


Figure 5. Resistive Switching Circuit

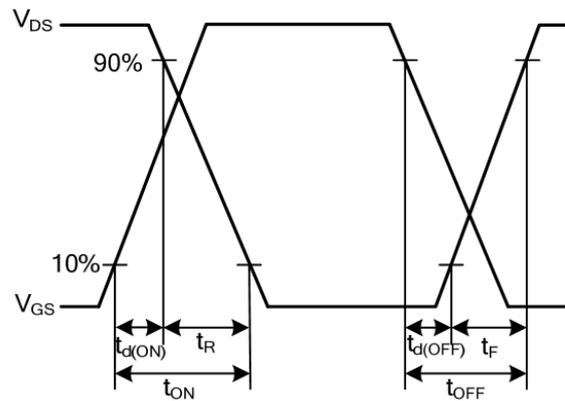


Figure 7. Resistive Switching Waveforms

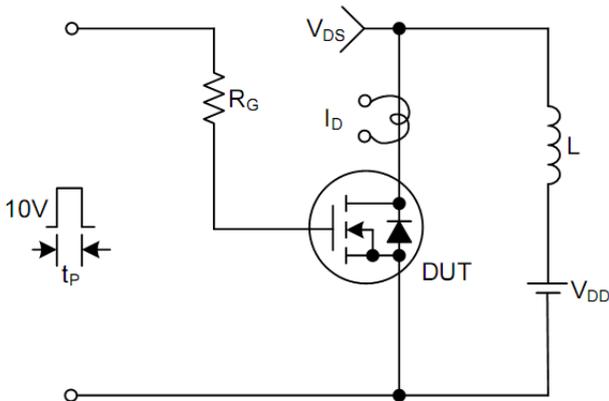


Figure 7. Unclamped Inductive Switching Test Circuit

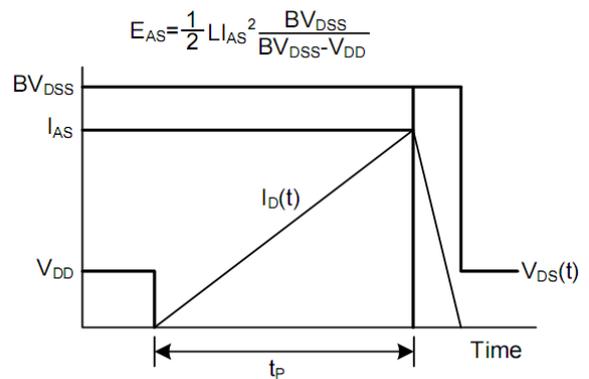


Figure 8. Unclamped Inductive Switching Waveforms

Typical Characteristics

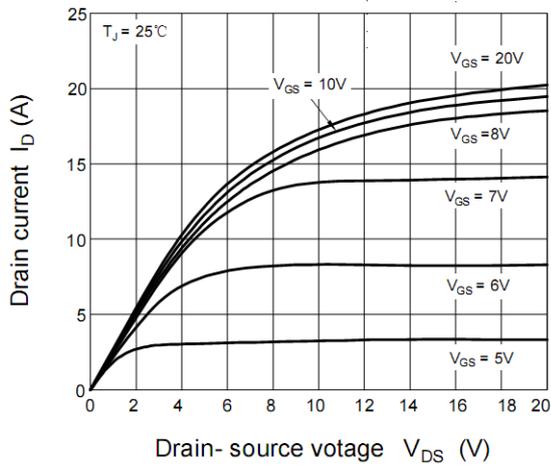


Figure 9 Output Characteristics

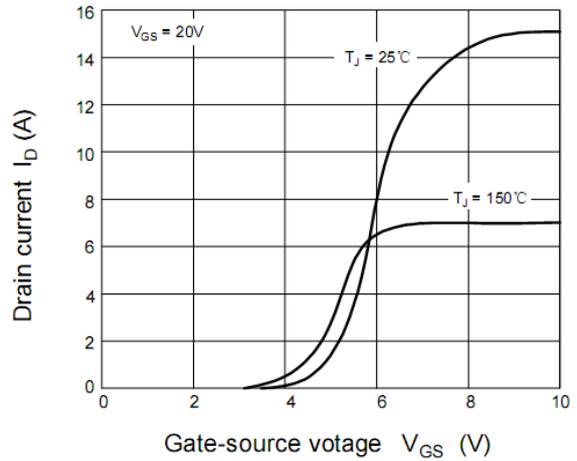


Figure 10. Transfer Characteristics

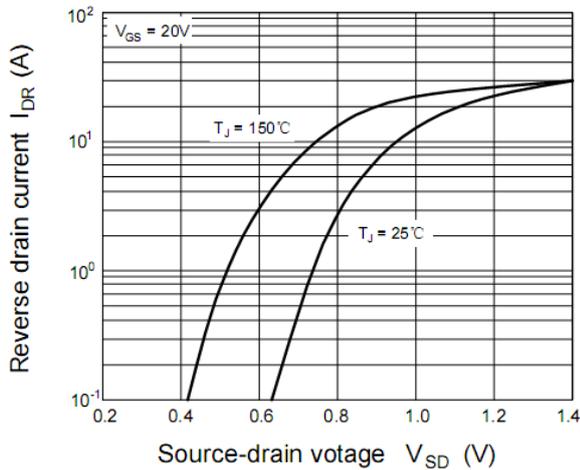


Figure 11. Body Diode Forward Voltage vs. Source current

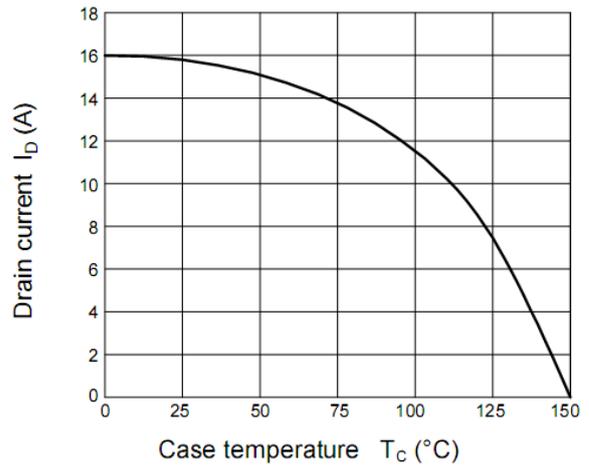


Figure 12. Drain current vs. Temperature

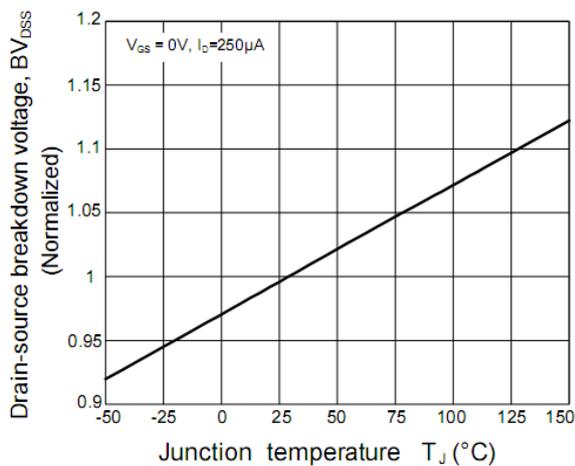


Figure 13. Breakdown Voltage Variation vs. temperature

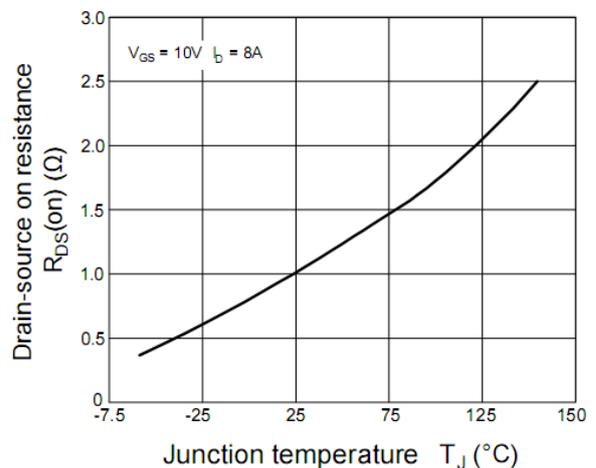


Figure 14. On-Resistance vs. Temperature

Typical Characteristics

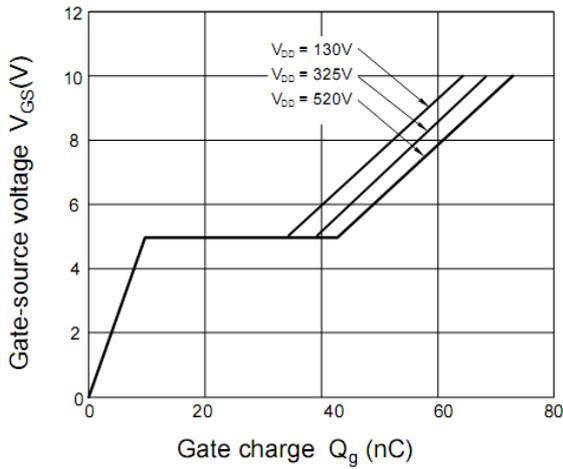


Figure 15. Typical Drain to Source ON Resistance vs Drain Current

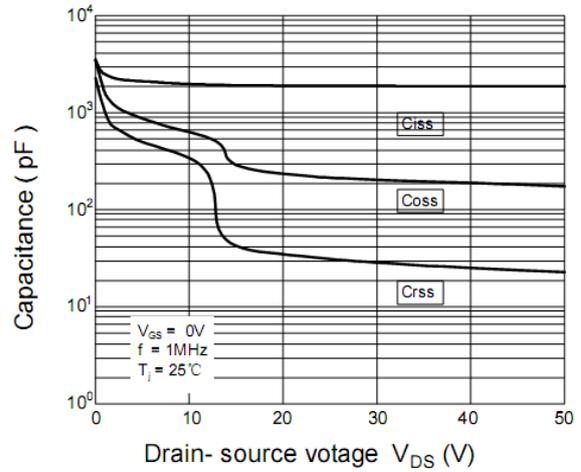


Figure 16. Capacitance vs Drain to Source Voltage

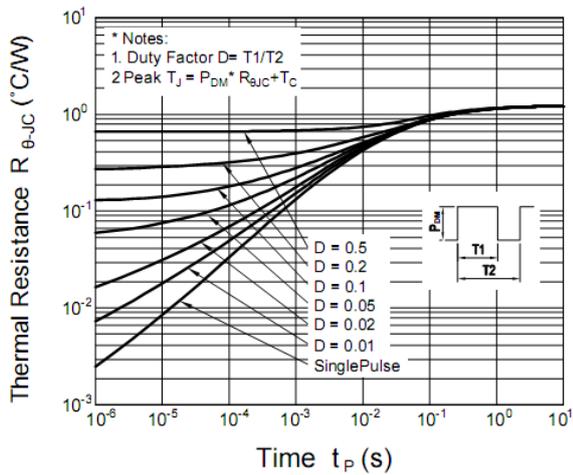


Figure 17. Transient Thermal Impedance

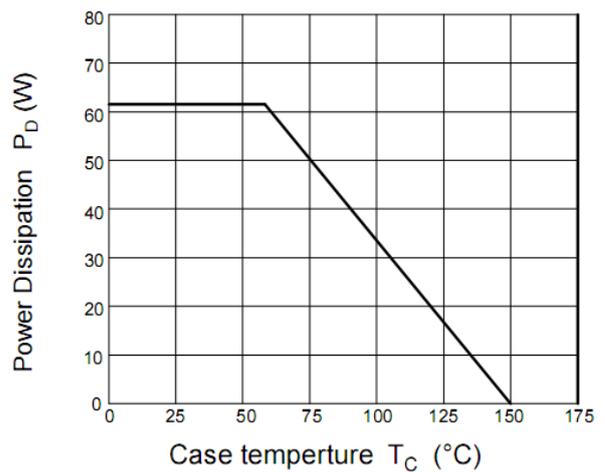


Figure 18. Power Derating

Package Dimensions

